# Application/Control No. 10/063,285 Examiner BINH Q. TRAN Applicant(s)/Patent Under Reexamination HEPBURN ET AL. Art Unit Page 1 of 1

# Notice of References Cited

### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,420,316	12-1983	Frost et al.	55/523
	В	US-4,417,908	11-1983	Pitcher, Jr., Wayne H.	55/523
	С	US-5,655,212	08-1997	Sekhar et al.	428/552
	D	US-6,367,246 B1	04-2002	Hirota et al.	60/295
	Ε	US-5,497,620 A	03-1996	Stobbe, Per	60/303
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q		,			
	R					
	s					
	Т					

## NON-PATENT DOCUMENTS

	HOIN ATEM BOOMENTO						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	V						
	w						
	x						

<sup>&</sup>quot;A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.